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Innovative on-site infrasound metrology conducted in 2019 and 2020

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In order to improve the confidence in the results of measurements carried out in the field, on-site metrology is a key step. With the medium-term objective of being able to deploy a portable metrology system on different infrasound stations, CEA-DAM has tested an innovative system for calibrating its infrasound sensors. The first tests were conducted in November 2019 and September 2020 as part of the installation and certification of the IMS IS25 infrasound station in Guadeloupe. A total of 20 microbarometers were qualified on site. We present the equipments deployed, the methods used and the results of the measurements carried out. It appears that the preliminary results show a very good correspondence between the measurements performed in the field, under particular environmental conditions, and the measurements performed in the metrology laboratory. The method will be confronted to the metrology community within the framework of the European Infra-AUV project in 2022.

Promotional text

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